SN74ABT125Q-Q1 QUADRUPLE BUS BUFFER GATE WITH 3-STATE OUTPUTS

SCAS686B - DECEMBER 2002 - REVISED JANUARY 2008

- Qualified for Automotive Applications
- Typical V_{OLP} (Output Ground Bounce)
 V at V_{CC} = 5 V, T_A = 25°C
- High-Drive Outputs (-16-mA I_{OH}, 32-mA I_{OL})
- I_{off} and Power-Up 3-State Support Hot Insertion
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)

D PACKAGE (TOP VIEW) 10E 14 V_{CC} 1A 🛮 2 13 **∏** 40E 1Y 🛮 3 12 🛮 4A 20E ∏ 4 11 **∏** 4Y 10 T 3 OE 2A | 5 2Y **[**] 6 9 ∏ 3A GND [8 **∏** 3Y

description/ordering information

The SN74ABT125Q-Q1 quadruple bus buffer gate features independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable (OE) input is high.

This device is fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION[†]

	T _A	PACI	(AGE‡	ORDERABLE PART NUMBER	TOP-SIDE MARKING
ľ	-40°C to 125°C	SOIC - D	Tape and reel	SN74ABT125QDRQ1	ABT125Q

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

FUNCTION TABLE (each buffer)

INPL	JTS	OUTPUT
OE	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

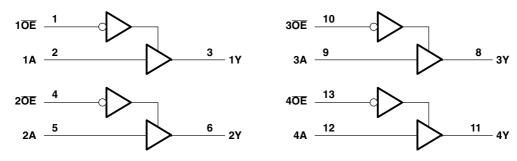


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[‡] Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, V _O	–0.5 V to 5.5 V
Current into any output in the low state, I _O	126 mA
Input clamp current, I _{IK} (V _I < 0)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Package thermal impedance, θ_{JA} (see Note 2)	86°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
V _{CC}	Supply voltage	4.5	5.5	V
V _{IH}	High-level input voltage	2		V
V _{IL}	Low-level input voltage		0.8	V
VI	Input voltage	0	V_{CC}	V
I _{OH}	High-level output current		-16	mA
I _{OL}	Low-level output current		32	mA
Δt/Δν	Input transition rise or fall rate		10	ns/V
Δt/ΔV _{CC}	Power-up ramp rate	200		μs/V
T _A	Operating free-air temperature	-40	125	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

2424		7707.001	IDITIONS	1	T _A = 25°(
PARA	METER	TEST CON	MIN	TYP†	MAX	MIN	MAX	UNIT		
V _{IK}		$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA			-1.2		-1.2	V	
		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.5			2.5			
V_{OH}		$V_{CC} = 5 V$,	$I_{OH} = -3 \text{ mA}$	3			3		V	
		V _{CC} = 4.5 V	I _{OH} = -16 mA	2			2			
V_{OL}		V _{CC} = 4.5 V	I _{OL} = 32 mA			0.55		0.55	V	
V_{hys}					100				mV	
I _I		$V_{CC} = 0 \text{ to } 5.5 \text{ V},$	$V_I = V_{CC}$ or GND			±1		±1	μΑ	
I_{OZPU}		$V_{CC} = 0$ to 2.1 V, $V_{O} = 0.5$ V to 2.	7 V, OE = X			±50		±50	μΑ	
I_{OZPD}		$V_{CC} = 2.1 \text{ V to } 0, V_{O} = 0.5 \text{ V to } 2.1 \text{ V} $	7 V, OE = X			±50		±50	μΑ	
I_{OZH}		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$	$V_O = 2.7 \text{ V}, \overline{OE} \ge 2 \text{ V}$			10 -10 ±100		10 –10	μΑ	
I_{OZL}		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$	$V_O = 0.5 \text{ V}, \overline{OE} \ge 2 \text{ V}$						μΑ	
I _{off}		$V_{CC} = 0$,	V_I or $V_O \le 4.5 \text{ V}$						μΑ	
I _{CEX}		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high					50	μΑ	
lo‡		$V_{CC} = 5.5 V,$	V _O = 2.5 V	-50	-100	-200§	-50	-200§	mA	
		$V_{CC} = 5.5 \text{ V},$	Outputs high		1	250		250	μΑ	
I _{CC}		$I_{O} = 0$,	Outputs low		24	30		30	mA	
		$V_I = V_{CC}$ or GND	Outputs disabled		0.5	250		250	μΑ	
	Data	V _{CC} = 5.5 V, One input at 3.4 V,	Outputs enabled			1.5		1.5		
ΔI_{CC} ¶	inputs	Other inputs at V _{CC} or GND	Outputs disabled			0.05		0.05	mA	
	Control inputs	V_{CC} = 5.5 V, One input at 3.4 V,	Other inputs at V _{CC} or GND	_		1.5		1.5		
Ci		V _I = 2.5 V or 0.5 V			3				pF	
Co		V _O = 2.5 V or 0.5 V			7				pF	

 $^{^{\}dagger}$ All typical values are at V_{CC} = 5 V.



[‡] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

 $[\]S$ This limit may vary among suppliers.

 $[\]P$ This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

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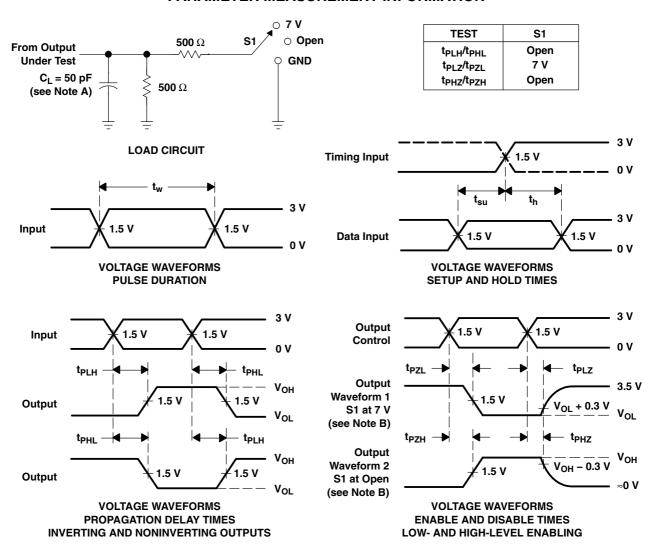
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO	V ₀	_{CC} = 5 V _A = 25°C	;	MIN	MAX	UNIT
	(INPUT)	(OUTPUT)	MIN	TYP	MAX			
t _{PLH} †		V	1	3.2	4.6	1	6	ns
t _{PHL} †	А	Y	1	2.5	4.6	1	6.2	
t _{PZH} †		Y	1	3.6	5	1	6	
t _{PZL} †	ŌĒ		1	2.5	6.2	1	7.5	ns
t _{PHZ}	OF.	V	1	3.8	5.4	1	6.3	
t _{PLZ} †	ŌĒ	ď	1	3.3	5.3	1	6.5	ns

[†] This limit may vary among suppliers.



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGE OPTION ADDENDUM

10-Dec-2020

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ABT125QDRG4Q1	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ABT125Q	Samples
SN74ABT125QDRQ1	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ABT125Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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10-Dec-2020

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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